Form PTO 1449		U.S. DEPARTMENT		ATTY DOCKET NO.		SERIAL NO.			
(Modified)		PATENT AND TRAC	JEMAKK OFFICE	289122US2PCT	10/574,548				
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LIST OF RE	EFER	ENCES CITED BY AP	PLICANT	Motoyasu TANAKA, et al.					
				FILING DATE		GROUP			
				February 21, 2007		2447			
U.S. PATENT DOCUMENTS									
EXAMINER	$\overline{}$	DOCUMENT	DATE	NAME CLASS		SUB CLASS			
INITIAL	. 	NUMBER			-	CLASS	CLASS IF APPROPRIATE		
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FOREIGN PATENT DOCUMENTS									
		DOCUMENT	DATE	COUNTRY		TRANSLATION			
		NUMBER	DATE			YES	3	NO	
A	AD	JP 11-328054	11/30/1999	Japan (corresponding to US 6,519,630 B1)				X	
	AP	JP 2001-245340	09/07/2001	Japan (with English Astracta and unedited computer-generated English translation)		×			
A	AQ	JP 2003-51029	02/21/2003	Japan (with English Astracta and unedited computer-generated English translation)		×			
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)									
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Examiner					Date Considered				
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.									